

Concept of nanodiffraction beamline on a new 4+ generation synchrotron radiation source. Beamline capabilities for solving material science problems

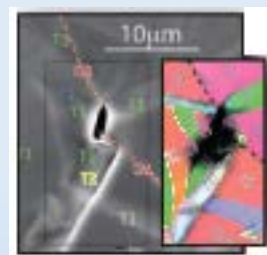
Igor Likhachev



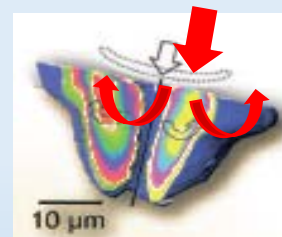
Micro- and nanoelectronics



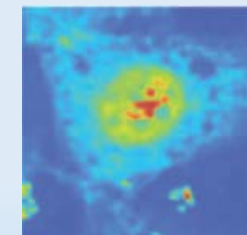
Material science



MEMS & NEMS



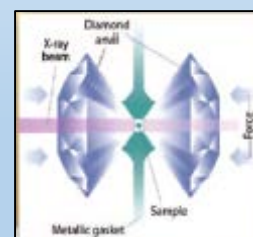
Cell biochemistry



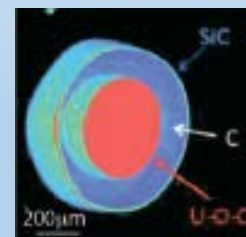
Protein crystallography



High pressure



Radioactive materials



Archeology



Basic techniques:

- X-ray diffraction techniques
- Coherent Bragg diffraction
- Bragg ptychography

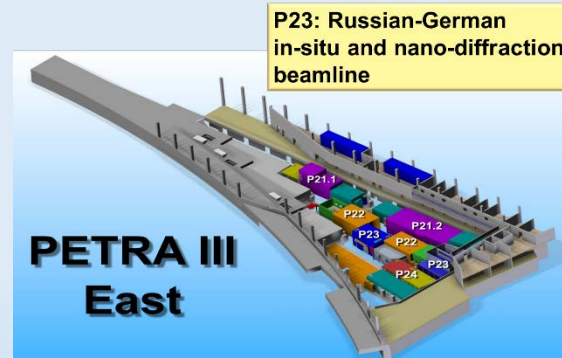
World analogues



ID01 @ESRF



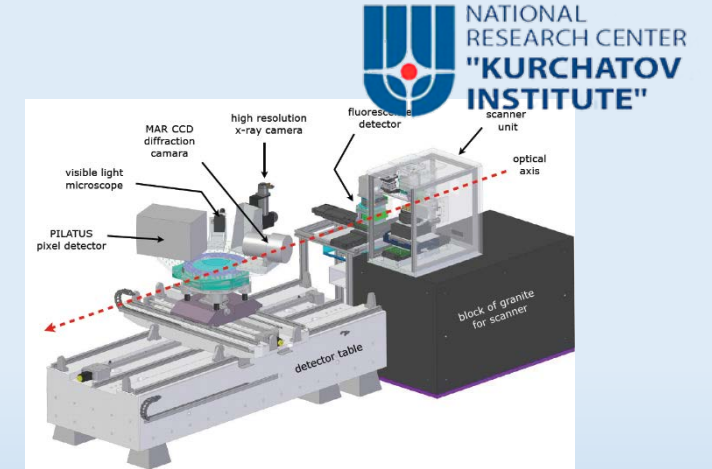
BL 12.3.2 @ALS



P23 @DESY



26-ID-C @APS



P06 @DESY



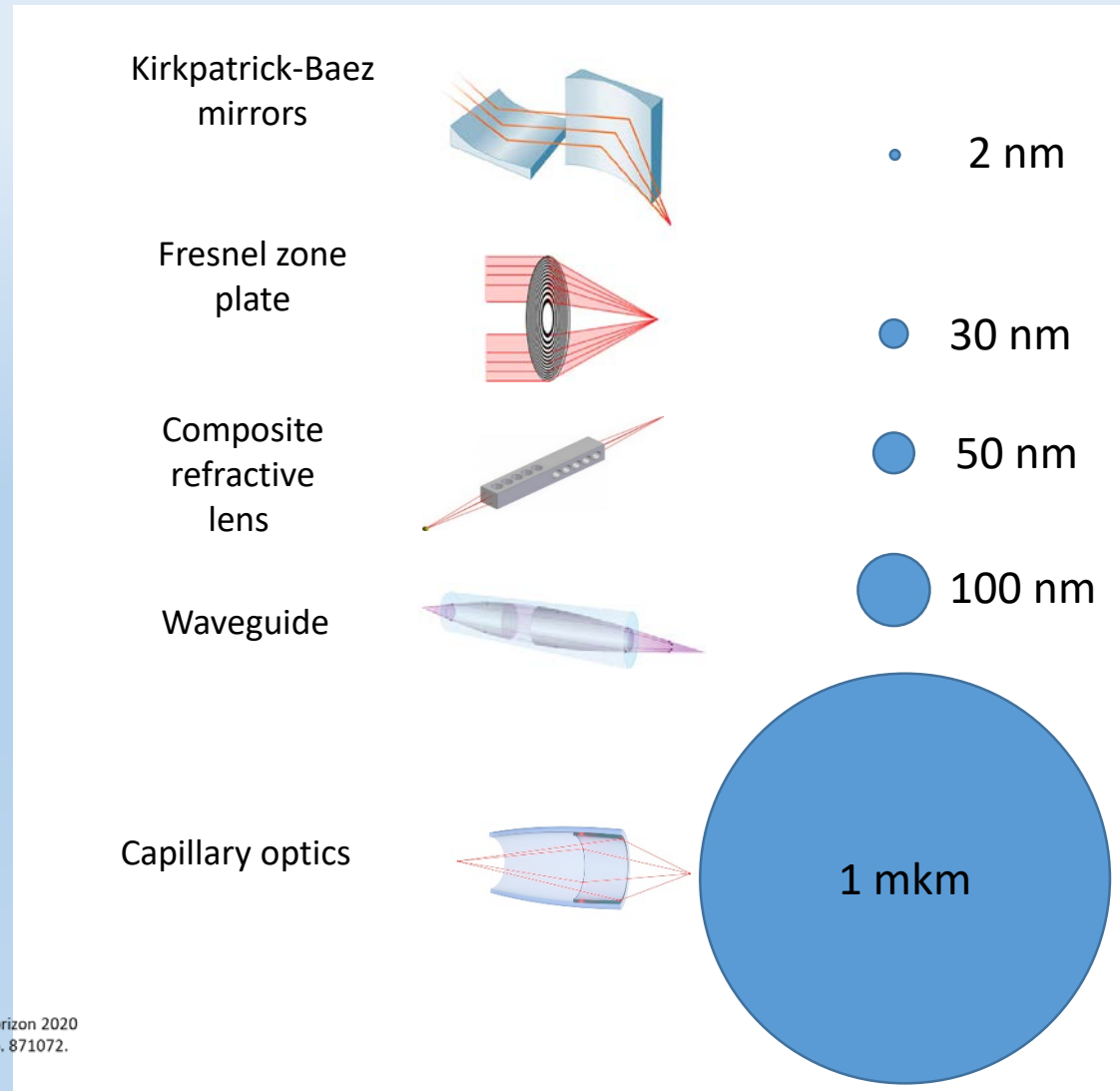
21A @TPS (Taiwan)



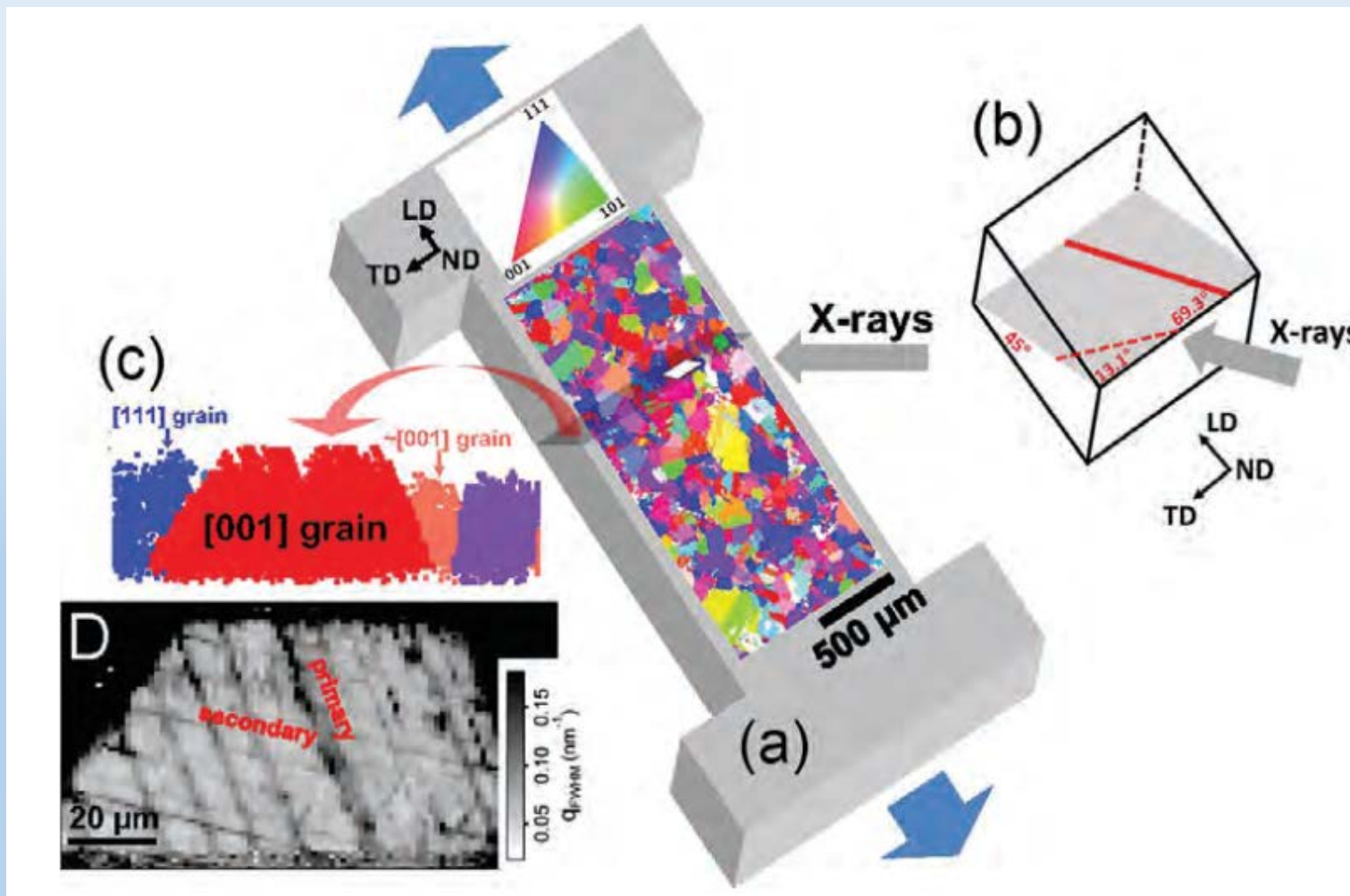
This project has received funding from the European Union's Horizon 2020 research and innovation programme under grant agreement No. 871072.

Methods for obtaining of nanosized x-ray beam

Minimum focus spot size



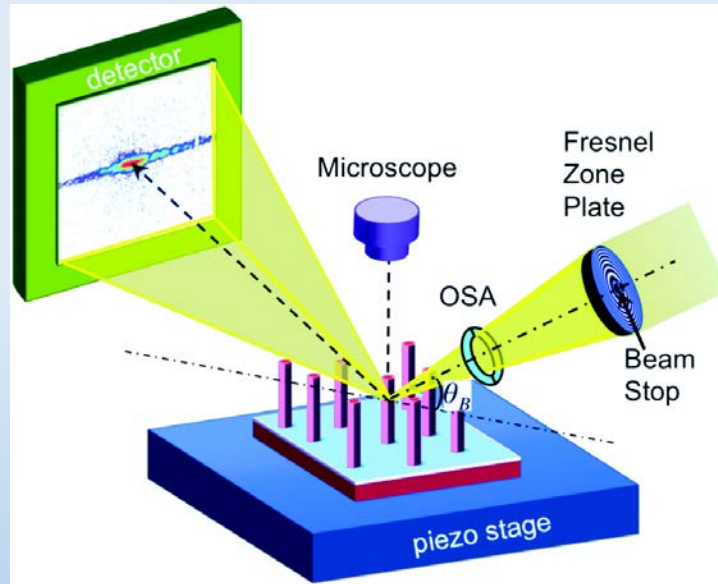
3D reconstruction of strained structure



Anastasios Pateras et al.
Mesoscopic Elastic Distortions in
GaAs Quantum Dot
Heterostructures. Nano
Lett. 2018 185 2780-2786

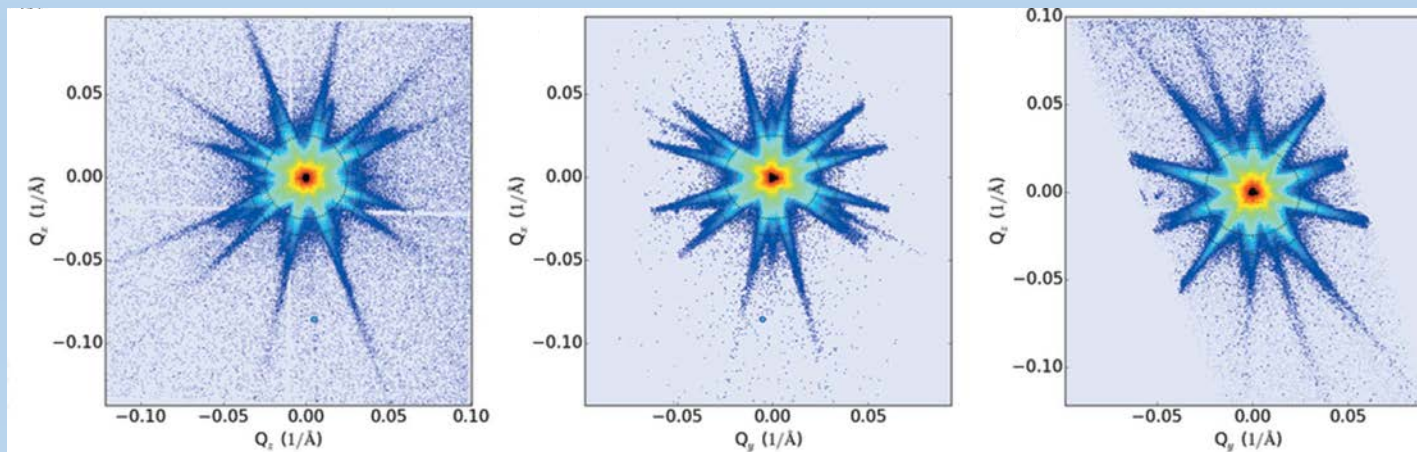
Coherent Bragg diffraction

Stéphane Labat et al.
Inversion Domain
Boundaries in GaN Wires
Revealed by Coherent
Bragg Imaging. ACS Nano
2015, 9, 9, 9210–9216



Objects:

- amorphous and disordered structures
- polymers
- crystal defects
- quantum dots and wires
- deformed structures and nanostructures
- buried layers and interfaces



Steven J. Leake et al. The Nanodiffraction beamline ID01/ESRF: a microscope for imaging strain and structure. J. Synchrotron Rad. (2019). 26, 571–584

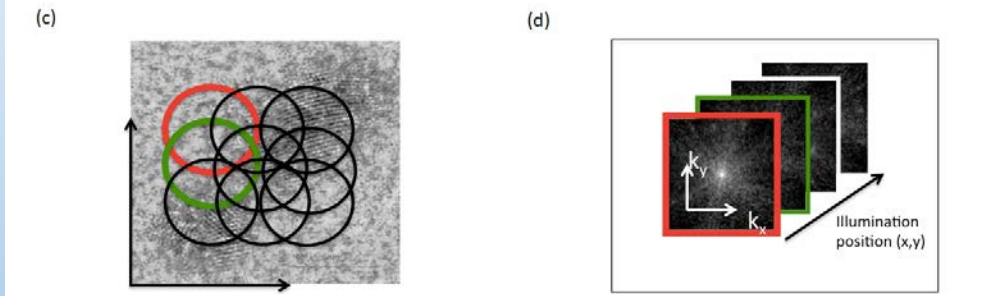
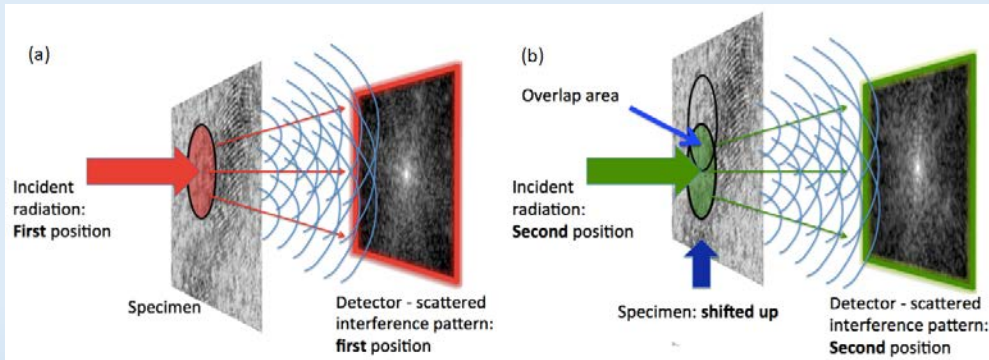
Functions:

- imaging of displacements (deformations) fields
- 3D reconstruction of nanoobjects
- imaging of nanoparticles, etc.

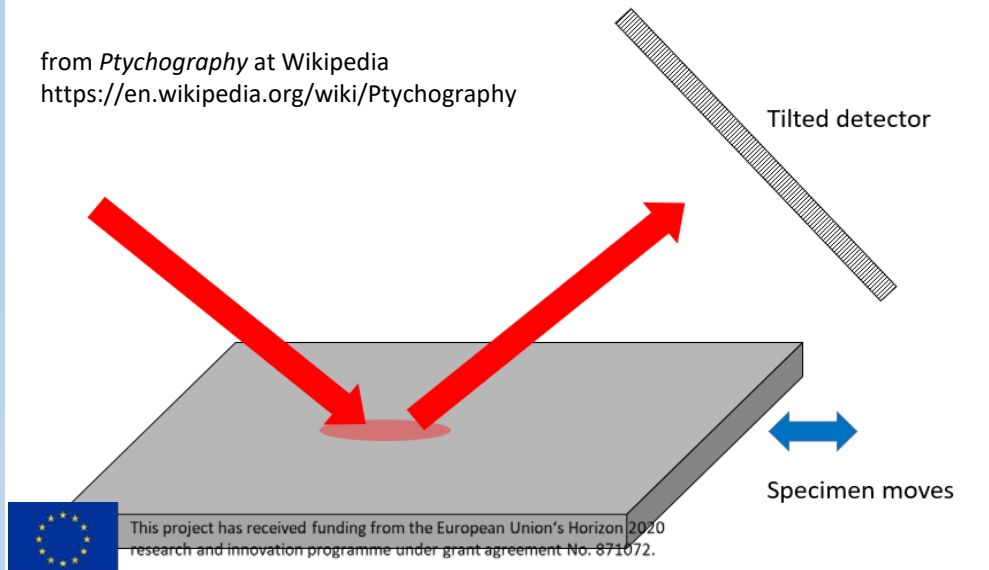


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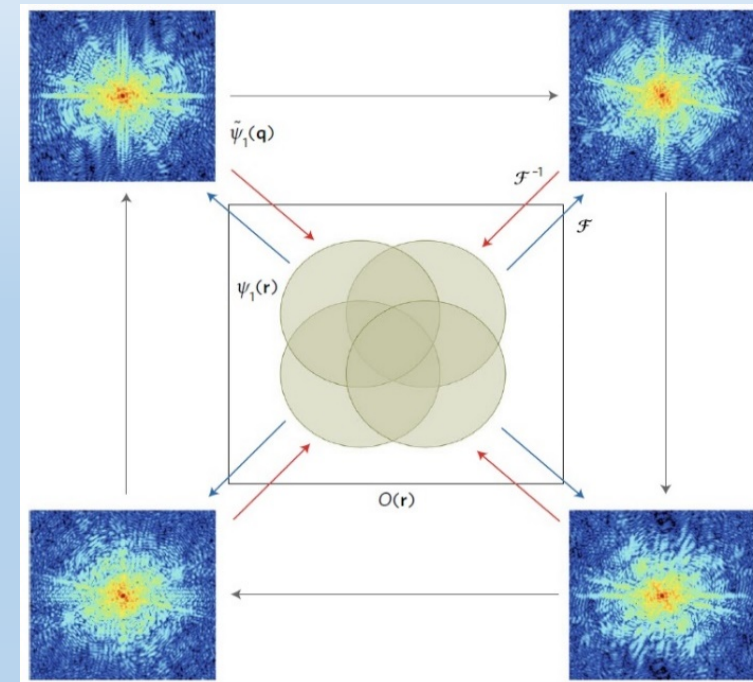
X-ray Bragg ptychography



from *Ptychography* at Wikipedia
<https://en.wikipedia.org/wiki/Ptychography>

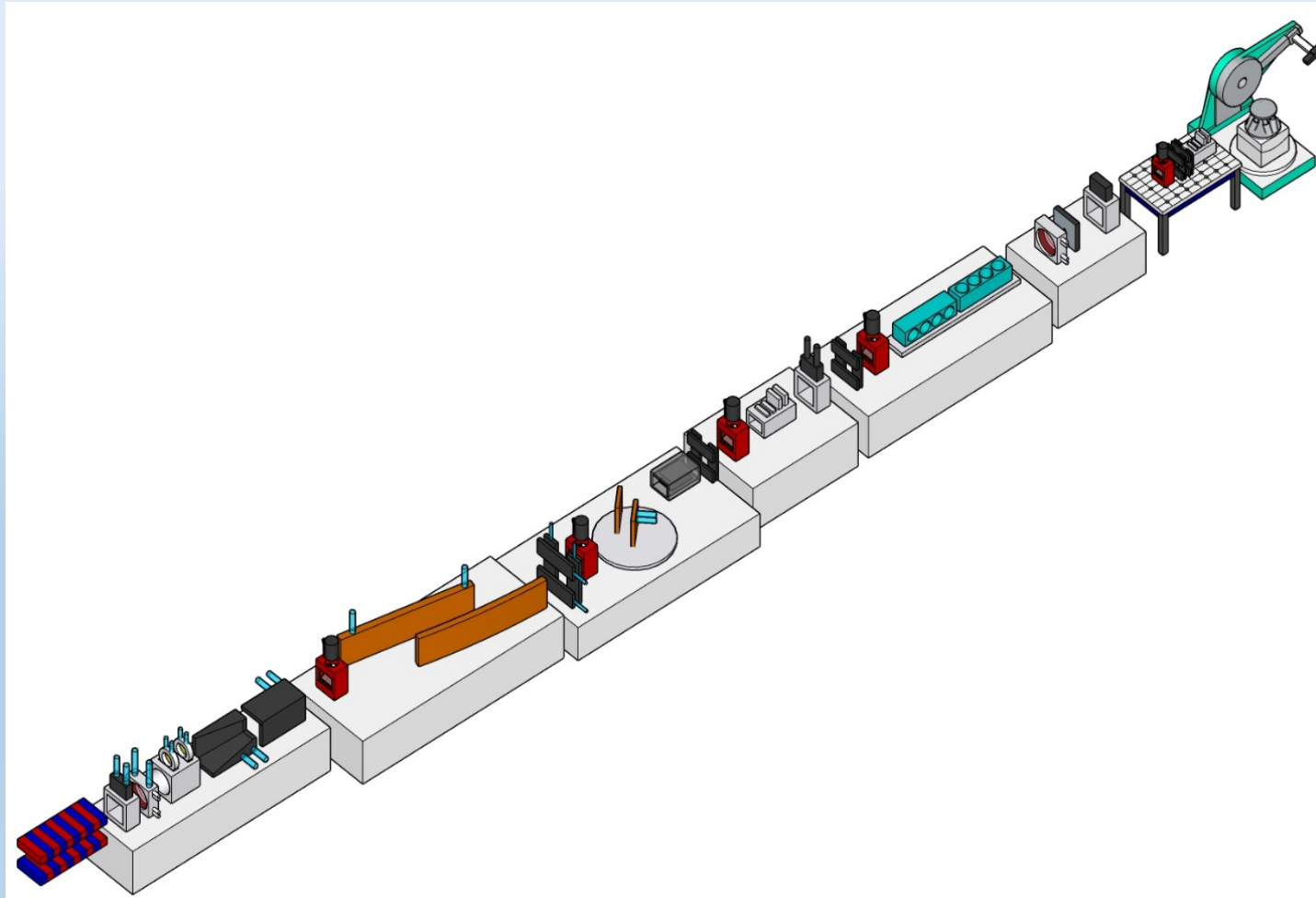


Special requirements are imposed on mechanical and temperature stability, since the slightest mechanical noise is critical during experiments in the sample scanning mode.



Martin Dierolf et al., *Ptychography & Lensing X-ray Imaging*.
Europhysics News, 39, 1, 22-24, 2008

Concept of optical scheme of nanodiffraction beamline



Energy range – 5-40 keV,

Source – undulator

Execution – vacuum path (before diffractometer)

Vacuum windows – diamond

Primary collimation (X-ray mirrors),
monochromatization (Si (111)), focusing (CRL
refractive lenses)

Secondary focusing - CRL, KB-mirrors, beam size
less than 50 nm

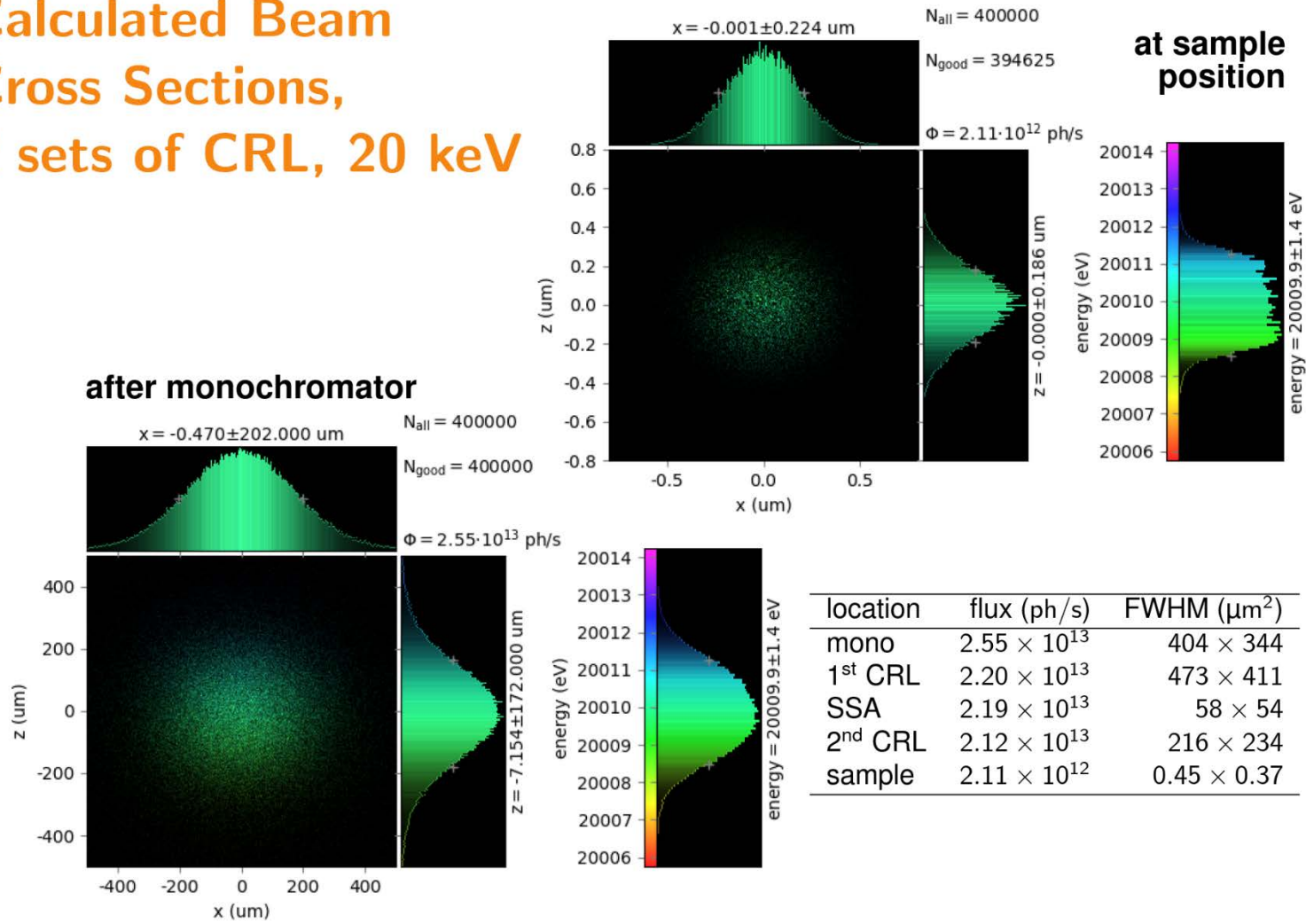
Research Instrument - High Precision
Diffractometer

Sample environment cameras



Concept of optical scheme of nanodiffraction beamline

Calculated Beam Cross Sections, 2 sets of CRL, 20 keV



M. Nentwich et al. Conceptual design of a scattering/diffraction beamline for the Russian synchrotron USSR // IUCr Congress, Prague, 2021

The nanodiffraction beamline is aimed to carry out structural studies of various materials and nanoscale objects, nanoparticles and microcrystallites, to identify individual defects and structural formations, microstresses and microdeformations with a time resolution of up to fractions of microseconds.

Applications of the beamline's capabilities: materials science, micro- and nanoelectronics, X-ray optics, etc., materials science, physics of nanosystems, physics of condensed matter, nanotechnology, development of new materials with specified characteristics.

The research results are potentially interesting for industry of microelectronics, instrument and mechanical engineering, metallurgy, energetics, space technologies, etc.



*Thank you for your
attention*

